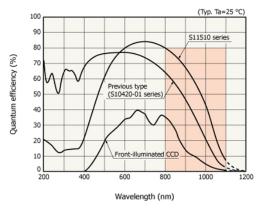
Wavelength Stable Back-Thinned 2D FFT CCD Array Spectrometers

Enhanced UV NIR Response





Control Development, Inc., offers high performance, high sensitivity spectrometers using a high quantum efficiency, thinned, and back-illuminated, *temperature stabilized* 2D FFT CCD array, exhibiting low noise and low dark levels. These spectrometers are especially suited for low light level applications. Two models are offered.

S10420 Series

Flat spectral response from 180nm to 1200nm High Q.E. from UV to NIR region S11510 Series Enhanced sensitivity in NIR region Q.E. 40% at 1000nm Ideally suited for Raman spectroscopy

Common Features

- Symmetric design resulting in lower stray light and tighter optical resolution
- High wavelength accuracy
- Low sensitivity to temperature changes
- Enhanced 8051 microprocessor
- 18 bit A/D (16 Bit displayed) with DAC offset
- Fast USB2.0 interface
- Non scanning device; acquire full spectrum in milliseconds!
- Small, rugged, portable

All our spectrometers include application software. CDI Spec32 is a data acquisition package with several data processing techniques included. Also supplied are our Lab View VI, Active X application, and DLLs.

All our devices are compact, rugged, portable and well suited for OEM applications. We will custom design spectrometers for your application usually at no extra charge.



Product Specifications

Part Numbers 2DCCD-10420 2DCCD-11510

Spectrometer

Spectral Range (nm)* 180-1200

Linear Dispersion (nm/pixel) defined by spectral range Resolution FWHM (nm) defined by linear dispersion

Wavelength Accuracy* ¼ pixel Input Fiber Options for both models

Single fiber Bundle Fiber

Core Diameter (microns) 400 50 (19 fibers) or 100 (7 or 19 fibers)

Material Ultra Low OH or High OH Ultra Low OH or High OH

Connector 905 SMA 905 SMA Input Slit Width (microns) 25, 50, 100 or none (fiber itself)

Optics f/3

Gratings

Lines/mm 200, 300, 400, 600, 1200, 1800, 2400, 3600

Coating Material Aluminum or Gold
Order Sorting Filter Available

*nominal, factory set, user-defined range in that spectral region

Detector

Material Type Silicon, thinned and back illuminated, UV and SWIR enhanced, high quantum efficiency

Number of elements 1024 H X 64 V Pixel Dimensions (WxH) 14 µm X 14 µm

Active area 14.336mm H X 0.896mm V

Full well depth 80,000 e- Vertical 60,000 e- Vertical 200,000 e- Horizontal 300,000 e- Horizontal

Electronics

Integration times 3 ms to 167 s A/D Converter 16 Bit Read out speed 6 μs per pixel Readout Noise ** <4 counts RMS Offset DAC Yes **On-Board** Memory Microprocessor Enhanced 8051 Strobe TTL compatible

Lamp Drivers Two
*18 Bit A/D, 16 Bit displayed **nominal

Power Requirements

Voltage 5V DC Current 8.0 Amps Power supply Included

Communications USB2.0 Interface

Internal Wavelength Calibration

Internal Mercury-Argon or Xenon line source available

Physical Dimensions

Dimensions 6.535"L X 4.173"W X 3.0"H

Weight 2 lb

Software

The following is included with every spectrometer purchase:

Spec32TM, DLLs, Lab View VI, Active X App, all with user manuals

Warranty and Support

Warranty 1 year Extended Warranty Available

Support Several support packages available Telephone 9:00 AM to 5:00 PM, EST, Mon-Fri.

Control Development, Inc.

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